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# 2N7002BKT

# 60 V, 290 mA N-channel Trench MOSFET Rev. 1 — 15 June 2010

Product data sheet

## **Product profile**

### 1.1 General description

N-channel enhancement mode Field-Effect Transistor (FET) in a small SOT416 (SC-75) Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

#### 1.2 Features and benefits

- Logic-level compatible
- Very fast switching
- Trench MOSFET technology
- ESD protection up to 2 kV
- AEC-Q101 qualified

## 1.3 Applications

- Relay driver
- High-speed line driver
- Low-side loadswitch
- Switching circuits

#### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	$T_{amb} = 25  ^{\circ}C$	-	-	60	V
$V_{GS}$	gate-source voltage	T <sub>amb</sub> = 25 °C	-	-	±20	V
I <sub>D</sub>	drain current	$T_{amb}$ = 25 °C; $V_{GS}$ = 10 V	[1] _	-	290	mA
R <sub>DSon</sub>	drain-source on-state resistance	$T_j = 25 ^{\circ}\text{C};$ $V_{GS} = 10 \text{V};$ $I_D = 500 \text{mA}$	-	1	1.6	Ω

<sup>[1]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.



#### 60 V, 290 mA N-channel Trench MOSFET

# 2. Pinning information

Table 2. Pinning

Table 2.	Filling			
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	S	source	3	D
3	D	drain	1 2	G S S S S S S S S S S S S S S S S S S S

# 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
2N7002BKT	SC-75	plastic surface-mounted package; 3 leads	SOT416

# 4. Marking

Table 4. Marking codes

Type number	Marking code
2N7002BKT	Z3

# 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage	T <sub>amb</sub> = 25 °C	-	60	V
$V_{GS}$	gate-source voltage	T <sub>amb</sub> = 25 °C	-	±20	V
$I_D$	drain current	$V_{GS} = 10 \text{ V}$	<u>[1]</u>		
		T <sub>amb</sub> = 25 °C	-	290	mA
		T <sub>amb</sub> = 100 °C	-	200	mA
I <sub>DM</sub>	peak drain current	$T_{amb}$ = 25 °C; single pulse; $t_p \le 10 \mu s$	-	1.2	Α

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#### 60 V, 290 mA N-channel Trench MOSFET

**Table 5.** Limiting values ...continued
In accordance with the Absolute Maximum Rating System (IEC 60134).

		• • •	•		
Symbol	Parameter	Conditions	Min	Max	Unit
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = 25 °C	<u>[2]</u> _	260	mW
			<u>[1]</u> _	320	mW
		T <sub>sp</sub> = 25 °C	-	820	mW
Tj	junction temperature			150	°C
T <sub>amb</sub>	ambient temperature		-55	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C
Source-d	rain diode				
I <sub>S</sub>	source current	T <sub>amb</sub> = 25 °C	<u>[1]</u> -	290	mA
ESD max	imum rating				
V <sub>ESD</sub>	electrostatic discharge voltage	human body model	<u>[3]</u> -	2000	V

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.
- [2] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.
- [3] Measured between all pins.

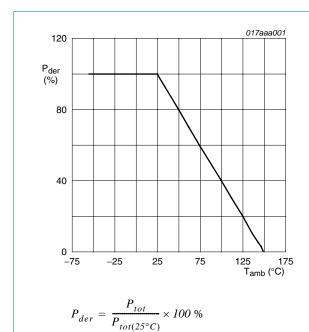
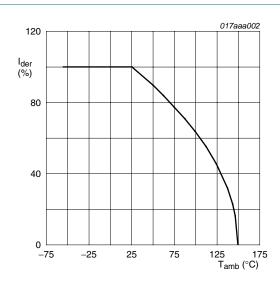


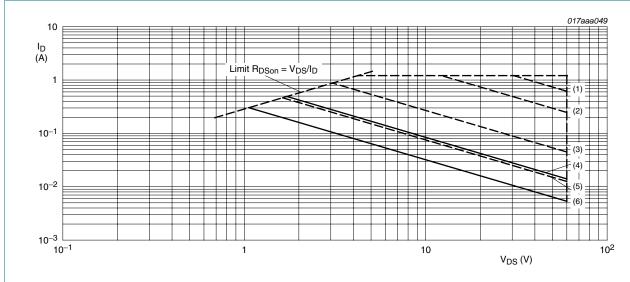
Fig 1. Normalized total power dissipation as a function of ambient temperature



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100 \%$$

Fig 2. Normalized continuous drain current as a function of ambient temperature

#### 60 V, 290 mA N-channel Trench MOSFET



I<sub>DM</sub> = single pulse

- (1)  $t_p = 100 \mu s$
- (2)  $t_p = 1 \text{ ms}$
- (3)  $t_p = 10 \text{ ms}$
- (4) DC;  $T_{sp} = 25 \, ^{\circ}C$
- (5)  $t_p = 100 \text{ ms}$
- (6) DC;  $T_{amb} = 25 \, ^{\circ}C$ ; drain mounting pad 1 cm<sup>2</sup>

Fig 3. Safe operating area; junction to ambient; continuous and peak drain currents as a function of drain-source voltage

#### 6. Thermal characteristics

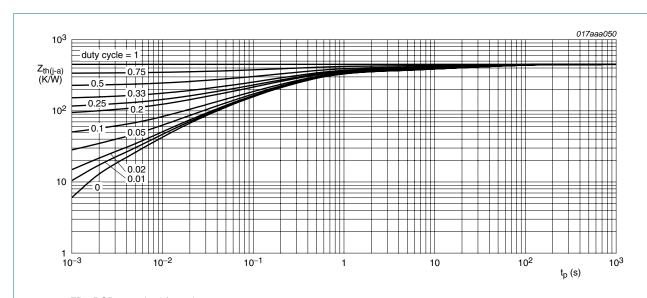
Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
ιτη () α)	thermal resistance from junction to ambient	in free air	<u>[1]</u> -	420	480	K/W
			[2] _	340	395	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	150	K/W

<sup>[1]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

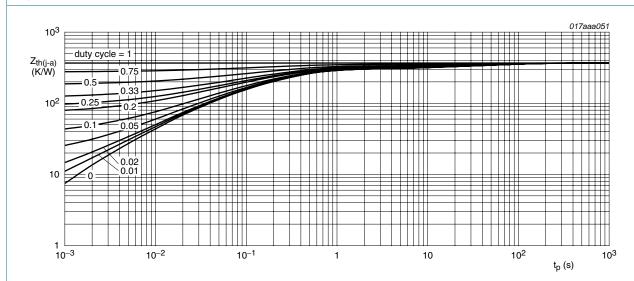
<sup>[2]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.

#### 60 V, 290 mA N-channel Trench MOSFET



FR4 PCB, standard footprint

Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



FR4 PCB, mounting pad for drain 1 cm<sup>2</sup>

Fig 5. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

## 60 V, 290 mA N-channel Trench MOSFET

## 7. Characteristics

**Table 7. Characteristics** 

 $T_i = 25$  °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 10 \mu A; V_{GS} = 0 V$	60	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 250 \ \mu A; \ V_{DS} = V_{GS}$	1.1	1.6	2.1	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 60 \text{ V}; V_{GS} = 0 \text{ V}$				
		T <sub>j</sub> = 25 °C	-	-	1	μΑ
		T <sub>j</sub> = 150 °C	-	-	10	μΑ
I <sub>GSS</sub>	gate leakage current	$V_{GS} = \pm 20 \text{ V}; V_{DS} = 0 \text{ V}$	-	-	10	μΑ
R <sub>DSon</sub>	drain-source on-state		[1]			
	resistance	$V_{GS} = 5 \text{ V}; I_D = 50 \text{ mA}$	-	1.3	2	Ω
		$V_{GS} = 10 \text{ V}; I_D = 500 \text{ mA}$	-	1	1.6	Ω
g <sub>fs</sub>	forward transconductance	$V_{DS} = 10 \text{ V}; I_D = 200 \text{ mA}$	<u>[1]</u> _	550	-	mS
Dynamic (	characteristics					
Q <sub>G(tot)</sub>	total gate charge	I <sub>D</sub> = 300 mA;	-	0.5	0.6	nC
Q <sub>GS</sub>	gate-source charge		-	0.2	-	nC
$Q_{GD}$	gate-drain charge	$I_{D} = 250 \ \mu\text{A}; \ V_{DS} = V_{GS}$ $V_{DS} = 60 \ V; \ V_{GS} = 0 \ V$ $T_{j} = 25 \ ^{\circ}\text{C}$ $T_{j} = 150 \ ^{\circ}\text{C}$ $V_{GS} = \pm 20 \ V; \ V_{DS} = 0 \ V$ $V_{GS} = 5 \ V; \ I_{D} = 500 \ \text{mA}$ $V_{DS} = 10 \ V; \ I_{D} = 200 \ \text{mA}$ $V_{DS} = 10 \ V; \ I_{D} = 200 \ \text{mA}$ $V_{DS} = 300 \ \text{mA};$ $V_{DS} = 30 \ V;$ $V_{GS} = 4.5 \ V$ $V_{GS} = 0 \ V; \ V_{DS} = 10 \ V;$ $f = 1 \ \text{MHz}$ $V_{DD} = 50 \ V;$ $V_{GS} = 10 \ V;$ $V_{GS} = 10 \ V;$ $V_{GS} = 6 \ \Omega$	-	0.1	-	nC
C <sub>iss</sub>	input capacitance	$\begin{split} I_D &= 250 \ \mu\text{A}; \ V_{DS} = V_{GS} \\ V_{DS} &= 60 \ V; \ V_{GS} = 0 \ V \\ \overline{T_j} &= 25 \ ^{\circ}\text{C} \\ \overline{T_j} &= 150 \ ^{\circ}\text{C} \\ V_{GS} &= \pm 20 \ V; \ V_{DS} = 0 \ V \\ \end{split}$	-	33	50	pF
Coss	output capacitance	f = 1 MHz	-	7	-	pF
C <sub>rss</sub>	reverse transfer capacitance		-	4	-	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DD} = 50 \text{ V};$	-	5	10	ns
t <sub>r</sub>	rise time		-	6	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	12	24	ns
t <sub>f</sub>	fall time		-	7	-	ns
Source-dr	ain diode					
V <sub>SD</sub>	source-drain voltage	$I_S = 115 \text{ mA}$ : $V_{GS} = 0 \text{ V}$	0.47	0.75	1.1	V

<sup>[1]</sup> Pulse test:  $t_p \le 300~\mu s;~\delta \le 0.01.$ 

10-3

#### 60 V, 290 mA N-channel Trench MOSFET

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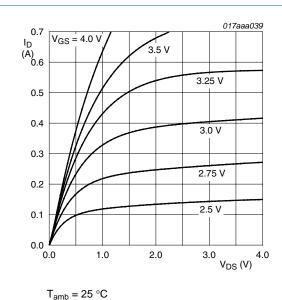
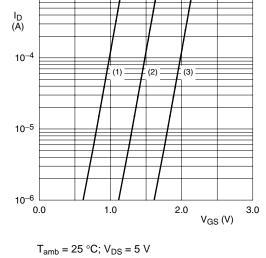
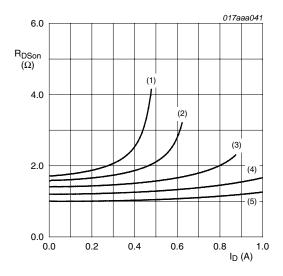


Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values



- (1) miniman value
- (2) typical values
- (3) maximum values

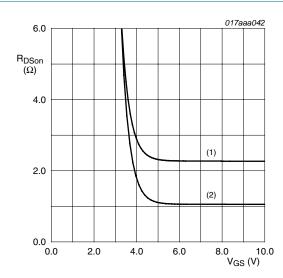
Fig 7. Sub-threshold drain current as a function of gate-source voltage



T<sub>amb</sub> = 25 °C

- (1)  $V_{GS} = 3.25 \text{ V}$
- (2)  $V_{GS} = 3.5 \text{ V}$
- (3)  $V_{GS} = 4 V$
- (4)  $V_{GS} = 5 \text{ V}$
- (5)  $V_{GS} = 10 \text{ V}$

Fig 8. Drain-source on-state resistance as a function of drain current; typical values

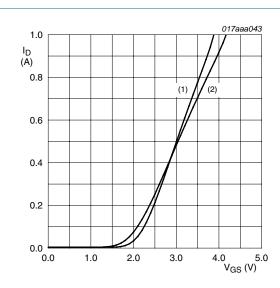


 $I_D = 500 \text{ mA}$ 

- (1)  $T_{amb} = 150 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$

Fig 9. Drain-source on-state resistance as a function of gate-source voltage; typical values

60 V, 290 mA N-channel Trench MOSFET

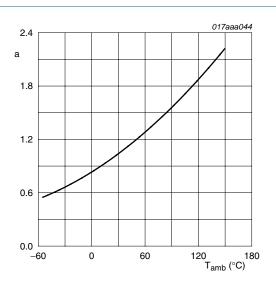


$$V_{DS} > I_{D} \times R_{DSon}$$

(1) 
$$T_{amb} = 25 \, ^{\circ}C$$

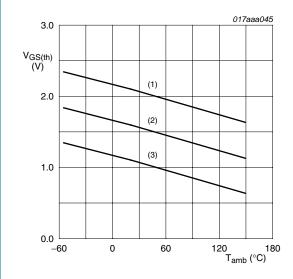
(2) 
$$T_{amb} = 150 \, ^{\circ}C$$

Fig 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values



$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

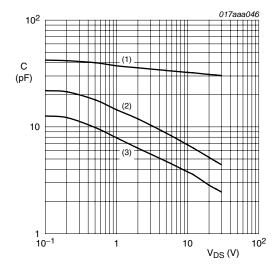
Fig 11. Normalized drain-source on-state resistance as a function of ambient temperature; typical values



 $I_D = 0.25 \text{ mA}; V_{DS} = V_{GS}$ 

- (1) maximum values
- (2) typical values
- (3) minimum values

Fig 12. Gate-source threshold voltage as a function of ambient temperature

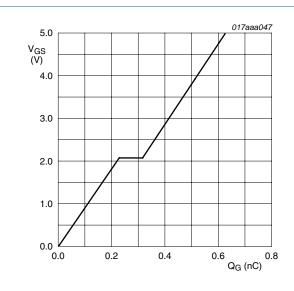


$$f = 1 \text{ MHz}; V_{GS} = 0 \text{ V}$$

- (1) C<sub>iss</sub>
- (2)  $C_{oss}$
- (3)  $C_{rss}$

Fig 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

#### 60 V, 290 mA N-channel Trench MOSFET



 $I_D$  = 300 mA;  $V_{DD}$  = 6 V;  $T_{amb}$  = 25 °C

Fig 14. Gate-source voltage as a function of gate charge; typical values

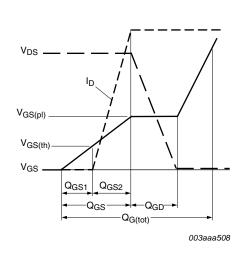
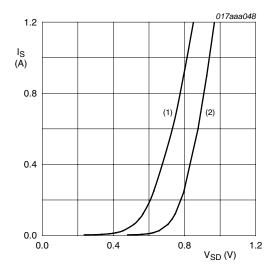


Fig 15. Gate charge waveform definitions



 $V_{GS} = 0 V$ 

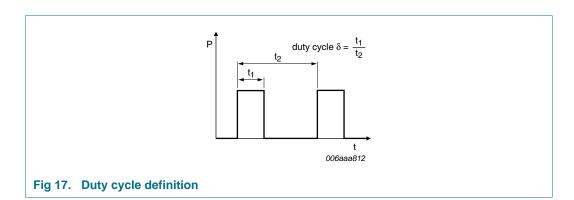
(1)  $T_{amb} = 150 \, ^{\circ}C$ 

(2)  $T_{amb} = 25 \, ^{\circ}C$ 

Fig 16. Source current as a function of source-drain voltage; typical values

60 V, 290 mA N-channel Trench MOSFET

# 8. Test information



# 9. Package outline

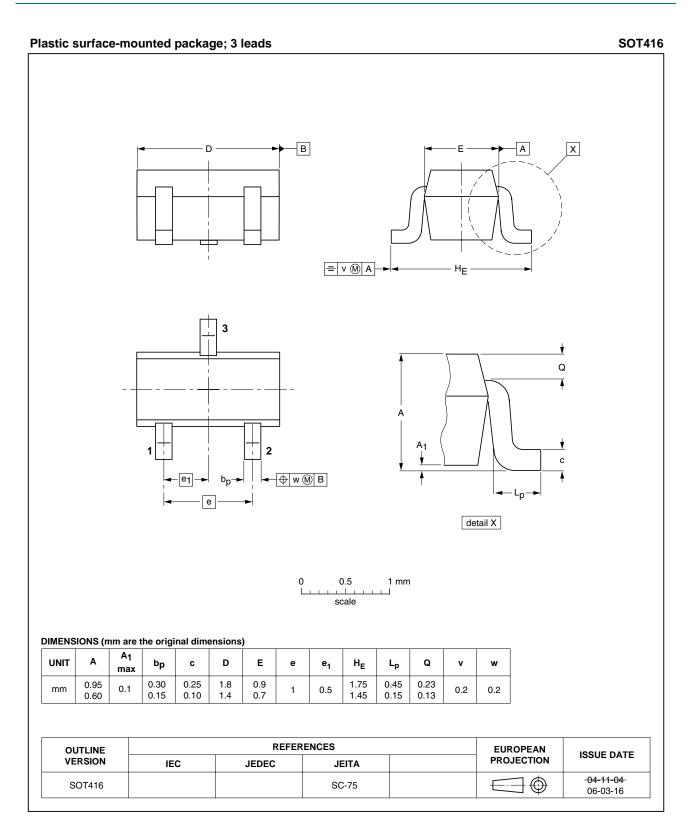


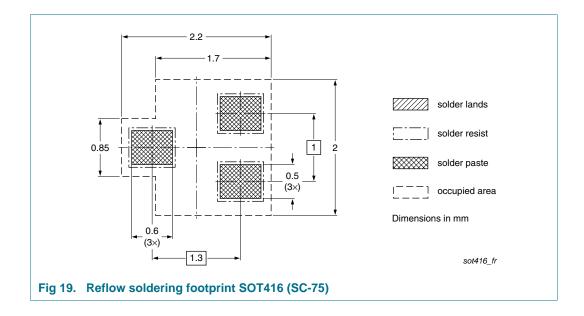
Fig 18. Package outline SOT416 (SC-75)

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## 60 V, 290 mA N-channel Trench MOSFET

# 10. Soldering



## 60 V, 290 mA N-channel Trench MOSFET

# 11. Revision history

#### Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
2N7002BKT v.1	20100615	Product data sheet	-	-

#### 60 V, 290 mA N-channel Trench MOSFET

## 12. Legal information

#### 12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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#### 60 V, 290 mA N-channel Trench MOSFET

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#### 60 V, 290 mA N-channel Trench MOSFET

## 14. Contents

1	Product profile	. 1
1.1	General description	. 1
1.2	Features and benefits	
1.3	Applications	. 1
1.4	Quick reference data	. 1
2	Pinning information	. 2
3	Ordering information	. 2
4	Marking	. 2
5	Limiting values	. 2
6	Thermal characteristics	. 4
7	Characteristics	. 6
8	Test information	10
9	Package outline	11
10	Soldering	12
11	Revision history	13
12	Legal information	14
12.1	Data sheet status	14
12.2	Definitions	14
12.3	Disclaimers	14
12.4	Trademarks	15
13	Contact information	15
14	Contents	16

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